

TRUSTWORTHY MULTI-FIDELITY AND DATA-DRIVEN MODELS FOR COMPUTATIONAL APPLICATIONS

Gianluca Geraci*¹ and Tian Yu Yen¹ and Daniele Schiavazzi² and Mohammad Motamed³ and Timothy
Willey¹

¹Sandia National Laboratories

²University of Notre Dame

³University of New Mexico

MINISYMPOSIUM

Emulators constructed from deep neural networks trained on data, have recently emerged as a computationally efficient alternative to solving complex systems of ordinary/partial differential equations that are often utilized in single- or multi-physics computational applications in science and engineering. However, the efficient, accurate, and stable training of state-of-the-art models requires large volumes of data extracted from high-fidelity numerical simulations or costly experiments, which effectively prohibits the application of these methods on high-fidelity applications. At the same time, there exists an opportunity to generate simplified models to generate multiple data sources by simplifying the high-fidelity numerical model, e.g., the discretization of PDEs or the underlying governing equations. Consequently, a limited quantity of high-fidelity outputs or experimental data can be supplemented with a substantial volume of results obtained from simplified models. The main drawback of these so-called “low-fidelity” models is that they are typically biased and do not retain the high-fidelity prediction capabilities necessary for trustworthy predictions. As a consequence, augmenting sparse, high-fidelity datasets with these less-expensive simulations requires careful consideration to avoid the corruption of information contained in the original high-fidelity model. This is often called “negative transfer” in the machine learning community. Several recent advancements in the areas of multi-fidelity and transfer learning have demonstrated the potential benefits of this approach. In this minisymposium, we will welcome contributions that develop, discuss and/or demonstrate approaches designed to lower the computational budget associated to the multi-fidelity training of high-fidelity data-driven models. We are particularly interested in contributions that assess the trustworthiness and reliability of the proposed emulators.

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